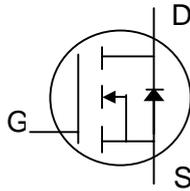




N-channel Enhancement-mode Power MOSFET

- 100% Avalanche-Tested**
- Simple Drive Requirement**
- Fast Switching Performance**
- RoHS-compliant, halogen-free**



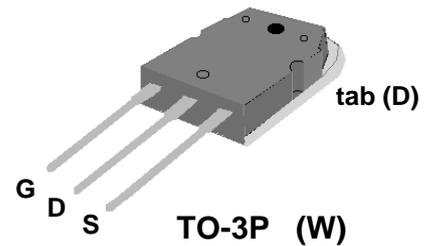
| | |
|--------------|------|
| BV_{DS} | 900V |
| $R_{DS(ON)}$ | 1.4Ω |
| I_D | 7.6A |

Description

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, low on-resistance and cost-effectiveness.

The AP09N90CW-HF-3 is in the TO-3P through-hole package which is widely used in higher power commercial and industrial applications where an attached heatsink is required.

This device is well suited for use in high voltage applications such as off-line AC/DC converters.



Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|-----------------------------|--|------------|-------|
| V_{DS} | Drain-Source Voltage | 900 | V |
| V_{GS} | Gate-Source Voltage | ±30 | V |
| I_D at $T_C=25^{\circ}C$ | Continuous Drain Current | 7.6 | A |
| I_D at $T_C=100^{\circ}C$ | Continuous Drain Current | 4.8 | A |
| I_{DM} | Pulsed Drain Current ¹ | 25 | A |
| P_D at $T_C=25^{\circ}C$ | Total Power Dissipation | 208 | W |
| E_{AS} | Single Pulse Avalanche Energy ² | 120 | mJ |
| I_{AR} | Avalanche Current | 6 | A |
| T_{STG} | Storage Temperature Range | -55 to 150 | °C |
| T_J | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Data

| Symbol | Parameter | Value | Units |
|--------|--|-------|-------|
| Rthj-c | Maximum Thermal Resistance, Junction-case | 0.6 | °C/W |
| Rthj-a | Maximum Thermal Resistance, Junction-ambient | 40 | °C/W |

Ordering Information

AP09N90CW-HF-3TB : in RoHS-compliant, halogen-free TO-3P, shipped in tubes



Electrical Specifications at $T_j=25^\circ\text{C}$ (unless otherwise specified)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|------------------------------|--|---|------|------|-----------|--------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=1mA$ | 900 | - | - | V |
| $\Delta BV_{DSS}/\Delta T_j$ | Breakdown Voltage Temperature Coefficient | Reference to 25°C , $I_D=1mA$ | - | 0.74 | - | $V/^\circ\text{C}$ |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance ³ | $V_{GS}=10V, I_D=3.6A$ | - | 1.25 | 1.4 | Ω |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu A$ | 2 | - | 4 | V |
| g_{fs} | Forward Transconductance | $V_{DS}=10V, I_D=3.6A$ | - | 3.6 | - | S |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=900V, V_{GS}=0V$ | - | - | 10 | μA |
| | Drain-Source Leakage Current ($T_j=125^\circ\text{C}$) | $V_{DS}=720V, V_{GS}=0V$ | - | - | 500 | μA |
| I_{GSS} | Gate-Source Leakage | $V_{GS}=\pm 30V, V_{DS}=0V$ | - | - | ± 100 | nA |
| Q_g | Total Gate Charge ³ | $I_D=7.2A$ | - | 50.7 | 80 | nC |
| Q_{gs} | Gate-Source Charge | $V_{DS}=540V$ | - | 12 | - | nC |
| Q_{gd} | Gate-Drain ("Miller") Charge | $V_{GS}=10V$ | - | 16 | - | nC |
| $t_{d(on)}$ | Turn-on Delay Time ³ | $V_{DD}=450V$ | - | 20 | - | ns |
| t_r | Rise Time | $I_D=7.2A$ | - | 16 | - | ns |
| $t_{d(off)}$ | Turn-off Delay Time | $R_G=6.8\Omega, V_{GS}=10V$ | - | 65 | - | ns |
| t_f | Fall Time | $R_D=62.5\Omega$ | - | 27 | - | ns |
| C_{iss} | Input Capacitance | $V_{GS}=0V$ | - | 3097 | 5000 | pF |
| C_{oss} | Output Capacitance | $V_{DS}=15V$ | - | 516 | - | pF |
| C_{riss} | Reverse Transfer Capacitance | $f=1.0\text{MHz}$ | - | 19 | - | pF |

Source-Drain Diode

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|----------|------------------------------------|------------------------|------|------|------|---------|
| V_{SD} | Forward On Voltage ³ | $I_S=7.2A, V_{GS}=0V$ | - | - | 1.5 | A |
| t_{rr} | Reverse Recovery Time ³ | $I_S=7.2A, V_{GS}=0V,$ | - | 673 | - | ns |
| Q_{rr} | Reverse Recovery Charge | $dI/dt=100A/\mu s$ | - | 9.6 | - | μC |

Notes:

1. Pulse width limited by maximum junction temperature.
2. Starting $T_j=25^\circ\text{C}$, $V_{DD}=50V$, $L=6.8mH$, $R_G=25\Omega$, $I_{AS}=6A$
3. Pulse test

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

APEC RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN.



Typical Electrical Characteristics

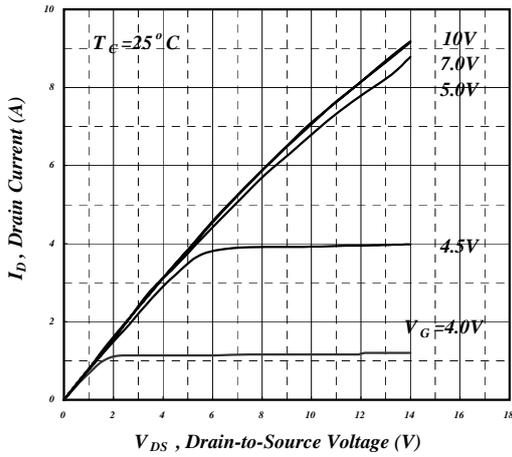


Fig 1. Typical Output Characteristics

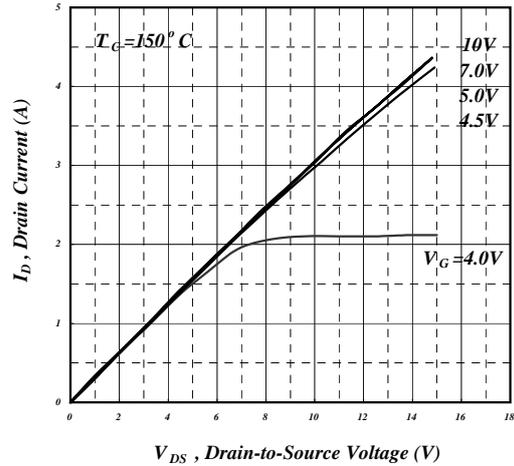


Fig 2. Typical Output Characteristics

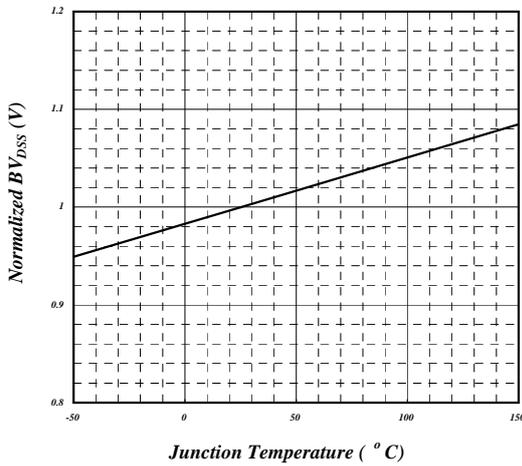


Fig 3. Normalized BV_{DSS} vs. Junction Temperature

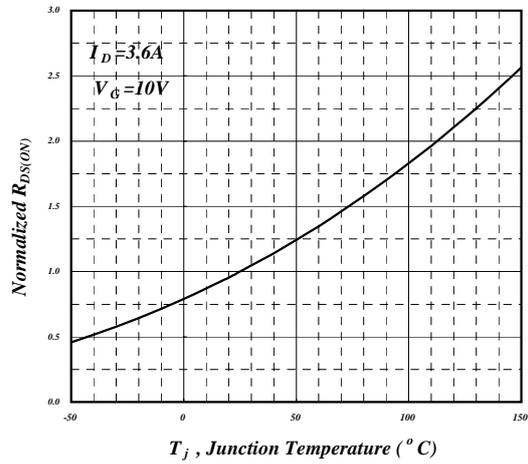


Fig 4. Normalized On-Resistance vs. Junction Temperature

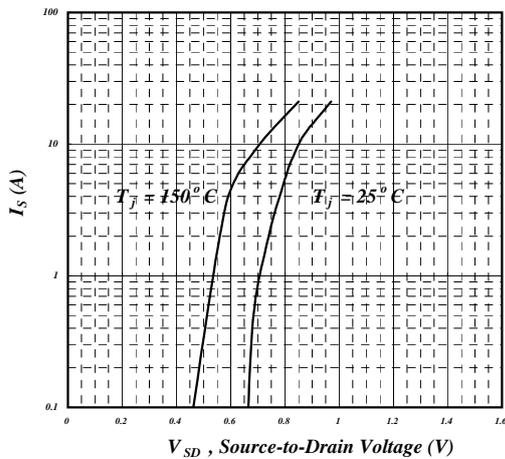


Fig 5. Forward Characteristic of Reverse Diode

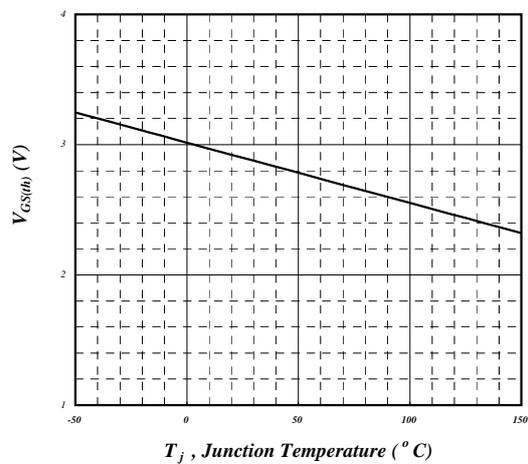


Fig 6. Gate Threshold Voltage vs. Junction Temperature



Typical Electrical Characteristics (cont.)

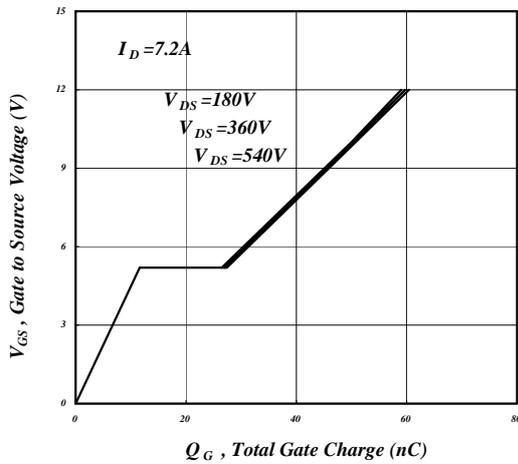


Fig 7. Gate Charge Characteristics

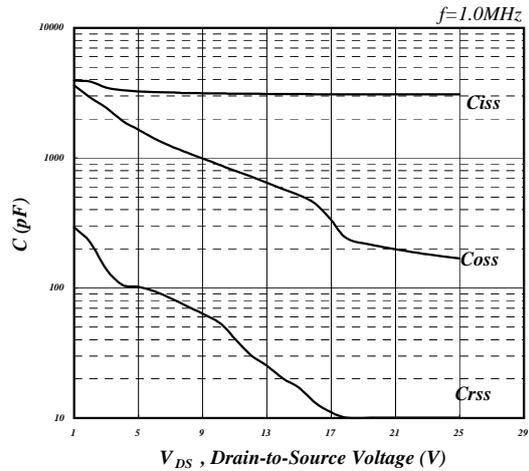


Fig 8. Typical Capacitance Characteristics

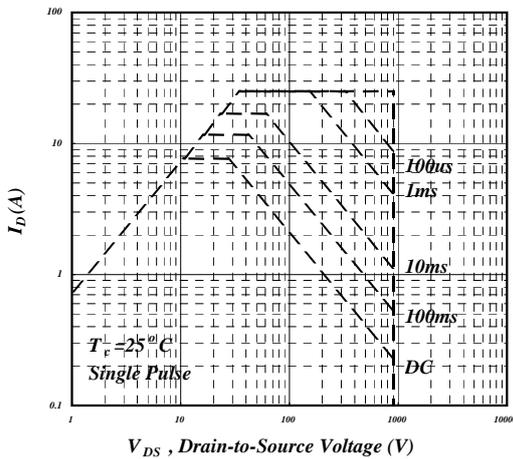


Fig 9. Maximum Safe Operating Area

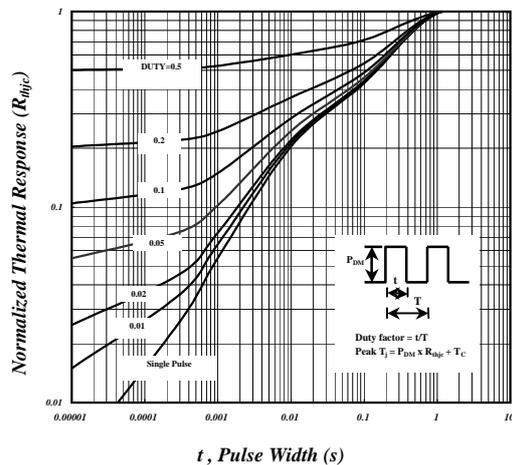


Fig 10. Effective Transient Thermal Impedance

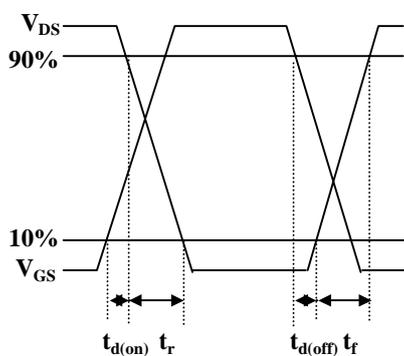


Fig 11. Switching Time Waveforms

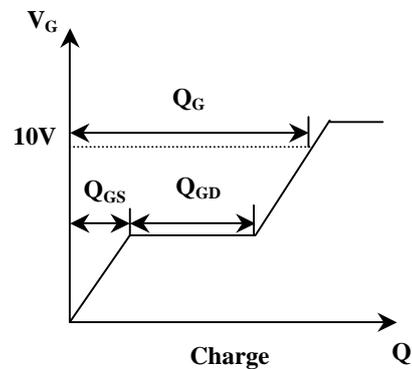
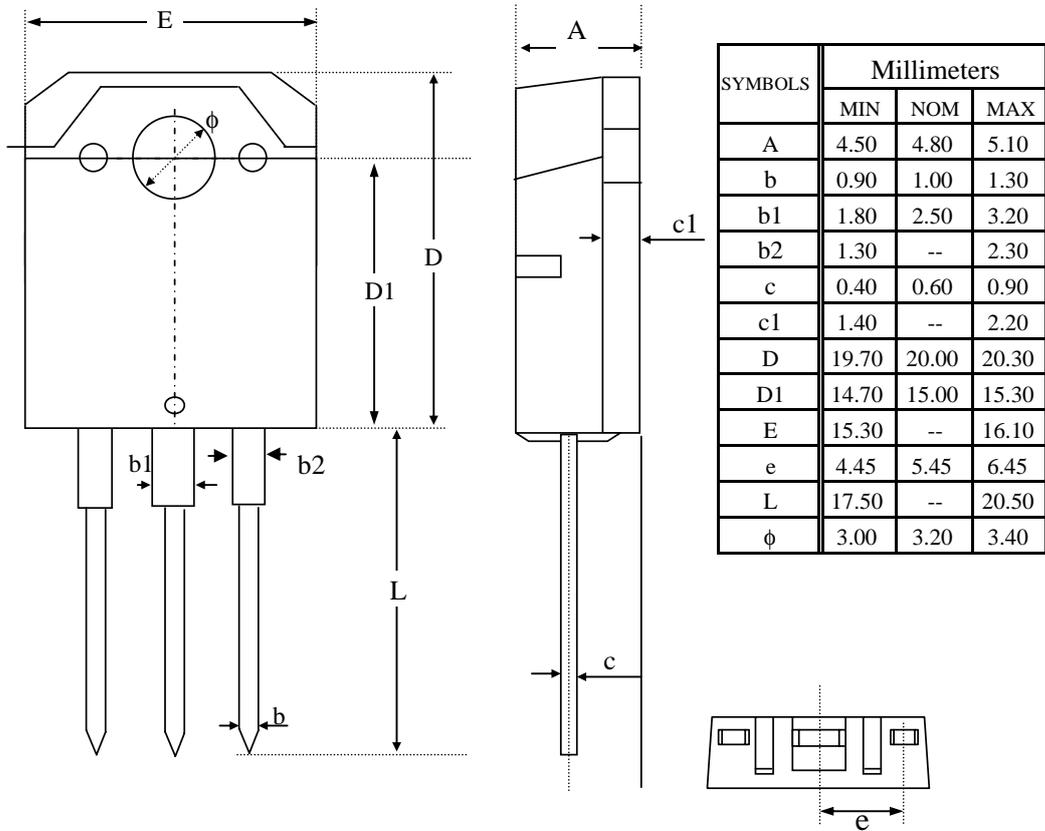


Fig 12. Gate Charge Waveform



Package Dimensions: TO-3P



1. All dimensions are in millimeters.
2. Dimensions do not include mold protrusions.

Marking Information:

